Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/538,501	OMURA ET AL.
Examiner	Art Unit
John P. Sheehan	1793

SEARCHED					
Class	Subclass	Date	Examiner		
	, ,				
	-				
	-				

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
-					
		,			
	Subclass	Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	1/6/2008	JPS	
· · · · · · · · · · · · · · · · · · ·			
		·	